



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 10/609,311
Filing Date June 26, 2003
Inventor Donald L. Yates
Assignee Micron Technology, Inc.
Group Art Unit 1756
Examiner Nicole M. Barreca
Attorney's Docket No. MI22-2236
Customer No. 021567
Title Semiconductor Processing Patterning Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference - - See attached Form PTO-1449

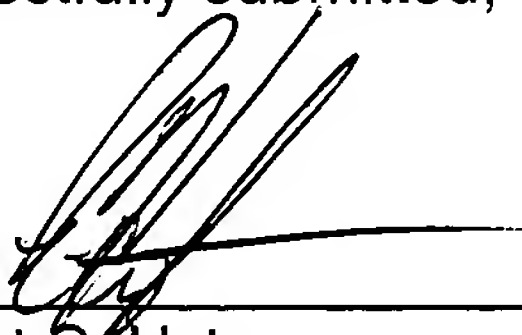
The attached Form PTO-1449 is submitted in compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. No admission is made regarding whether the submitted reference is prior art.

This Supplemental Information Disclosure Statement is being filed with a Response to Final Office Action to Accompany Request for Continued Examination (RCE). Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 6/7/06



Robert C. Hyta
Reg. No. 46,791

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

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GROUP
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LIST OF ART CITED BY APPLICANT
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U.S. PATENT DOCUMENTS

*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,994,194	11/99	Lammert			
	AB	6,582,861	06/03	Buxbaum, et al.			
	AC	6,838,363	01/05	Wieczorek, et al.			
	AD	6,956,980	10/05	Nagata, et al.			
	AE	2005/0244571	11/05	Walheim, et al.			
	AF	10/822,118	04/04	Sandhu, et al.			
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.